

033082M288

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): Yasuo Yatsugake, et al.

International Application No.: PCT/JP2004/005633

International Filing Date: April 20, 2004

U.S. Serial No.: To Be Assigned

Group Art Unit: To Be Assigned

Filed: : Herewith

Examiner: To Be Assigned

For: SEMICONDUCTOR MANUFACTURING SYSTEM

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450


Sir:

Pursuant to the duty of disclosure under 37 C.F.R. 1.56, Applicants are enclosing an Information Disclosure Citation Form (PTO-1449) which lists the documents noted in the International Search Report being filed herewith. According to the Search Report, document AA is a counterpart of document AH, document AB is a counterpart of document AI and document AC is a counterpart of document AJ. Copies of the cited non-U.S. documents are enclosed.

It is respectfully requested that the cited documents be considered by the Examiner in the above-identified patent application and that the cited documents be made officially of record therein. It is further requested that a listing of the same appear on the face of any patent which may issue from this application.

Respectfully submitted,  
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October 21, 2005

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| FORM PTO-1449<br><br>INFORMATION DISCLOSURE STATEMENT | ATTY. DOCKET<br>033082M288            | SERIAL NO.<br>107554007<br>To Be Assigned |
|   | APPLICANT:<br>Yasuo Yatsugake, et al. |   |
|   | FILING DATE<br>Herewith               | GROUP ART UNIT<br>To Be Assigned          |

**U.S. PATENT DOCUMENTS**

| *Examiner's<br>Initials |    | DOCUMENT<br>NUMBER | DATE    | NAME              | CLASS | SUB-<br>CLASS | FILING DATE,<br>IF APPROPRIATE |
|-------------------------|----|--------------------|---------|-------------------|-------|---------------|--------------------------------|
|                         | AA | 6,597,448          | 7/22/03 | Nishiyama, et al. |       |               |                                |
|                         | AB | 2002/0047097       | 4/25/02 | Nishiyama, et al. |       |               |                                |
|                         | AC | 5,801,965          | 9/1/98  | Takagi, et al.    |       |               |                                |
|                         | AD |                    |         |                   |       |               |                                |
|                         | AE |                    |         |                   |       |               |                                |
|                         | AF |                    |         |                   |       |               |                                |
|                         | AG |                    |         |                   |       |               |                                |

**FOREIGN PATENT DOCUMENTS**

| *Examiner's<br>Initials |    | DOCUMENT<br>NUMBER | DATE    | COUNTRY | CLASS | SUB-<br>CLASS | TRANSLATION<br>YES NO |  |
|-------------------------|----|--------------------|---------|---------|-------|---------------|-----------------------|--|
|                         | AH | 2001-264264        | 9/26/01 | Japan   |       |               | Abstract              |  |
|                         | AI | 2003-098111        | 4/3/03  | Japan   |       |               | Abstract              |  |
|                         | AJ | 07-201946          | 8/4/95  | Japan   |       |               | Abstract              |  |
|                         | AK |                    |         |         |       |               |                       |  |
|                         | AL |                    |         |         |       |               |                       |  |
|                         | AM |                    |         |         |       |               |                       |  |
|                         | AN |                    |         |         |       |               |                       |  |

**OTHER INFORMATION** (Including Author, Title, Date, Pertinent Pages, Etc.)

|  |    |                  |
|--|----|------------------|
|  | AO |                  |
|  | AP |                  |
|  | AQ |                  |
| EXAMINER:  |    | DATE CONSIDERED: |
| <p>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p> |    |                  |